



Material No.: 9731-03 Batch No.: 0000122355 Manufactured Date: 2015/09/15

Retest Date: 2020/09/13

Certificate of Analysis

Passes Test	PT
28.0 - 30.0 %	29.2
<= 7	5
<= 1 ppm	< 1
<= 3 ppm	< 3
<= 10 ppm	< 10
Passes Test	PT
Passes Test	PT
<= 0.3 ppm	< 0.2
<= 0.2 ppm	< 0.1
<= 0.8 ppm	0.2
<= 10.0 ppb	< 5.0
<= 50.0 ppb	< 2.0
<= 30 ppb	< 5
<= 10.0 ppb	< 1.0
<= 10.0 ppb	< 1.0
<= 20.0 ppb	< 10.0
<= 10.0 ppb	< 5.0
<= 5.0 ppb	< 1.0
<= 100.0 ppb	1.0
<= 5.0 ppb	< 1.0
<= 1.0 ppb	< 1.0
<= 10.0 ppb	< 1.0
<= 10.0 ppb	< 1.0
	<= 7 <= 1 ppm <= 3 ppm <= 10 ppm Passes Test Passes Test Passes Test <= 0.3 ppm <= 0.2 ppm <= 0.8 ppm <= 10.0 ppb <= 50.0 ppb <= 30 ppb <= 10.0 ppb <= 5.0 ppb <= 10.0 ppb <= 5.0 ppb <= 10.0 ppb <= 1.0 ppb <= 1.0 ppb <= 1.0 ppb <= 1.0 ppb

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Test	Specification	Result
Trace Impurities – Germanium (Ge)	<= 50.0 ppb	< 10.0
Trace Impurities – Gold (Au)	<= 10.0 ppb	< 5.0
Heavy Metals (as Pb)	<= 200 ppb	< 100
Trace Impurities – Iron (Fe)	<= 10.0 ppb	1.0
Trace Impurities – Lead (Pb)	<= 10.0 ppb	< 10.0
Trace Impurities – Lithium (Li)	<= 10.0 ppb	< 1.0
Trace Impurities – Magnesium (Mg)	<= 50.0 ppb	< 1.0
Trace Impurities – Manganese (Mn)	<= 5.0 ppb	< 1.0
Trace Impurities – Molybdenum (Mo)	<= 10.0 ppb	< 5.0
Trace Impurities – Nickel (Ni)	<= 5.0 ppb	< 5.0
Trace Impurities – Niobium (Nb)	<= 10.0 ppb	< 1.0
Frace Impurities – Potassium (K)	<= 100.0 ppb	< 10.0
Trace Impurities – Silicon (Si)	<= 150.0 ppb	< 10.0
Frace Impurities – Silver (Ag)	<= 5.0 ppb	< 1.0
Trace Impurities – Sodium (Na)	<= 100.0 ppb	< 5.0
Trace Impurities – Strontium (Sr)	<= 10.0 ppb	< 1.0
Frace Impurities – Tantalum (Ta)	<= 10.0 ppb	< 5.0
Trace Impurities – Thallium (Tl)	<= 20.0 ppb	< 5.0
Frace Impurities – Tin (Sn)	<= 20.0 ppb	< 10.0
Trace Impurities – Titanium (Ti)	<= 10.0 ppb	< 1.0
Trace Impurities – Vanadium (V)	<= 10.0 ppb	< 1.0
Frace Impurities – Zinc (Zn)	<= 5.0 ppb	< 1.0
Frace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 1.0
Particle Count – 0.5 µm and greater	<= 80 par/ml	26
Particle Count – 1.0 µm and greater	<= 10 par/ml	5

For Microelectronic Use

Country of Origin: US

Packaging Site: Phillipsburg Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
Paris, KY 9001:2008
Mexico City, Mexico 9001:2008
Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
Gliwice, Poland 9001:2008
Selangor, Malaysia 9001:2008
Dehradun, India, 9001:2008, 14001:2004, 13485:2003
Mumbai, India, 9001:2008, 17025:2005

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